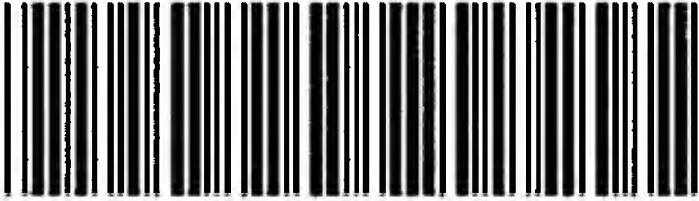


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,515	CHANG, YUAN-HU	
	Examiner	Art Unit	
	Matthew G. Kayrish	2653	

SEARCHED			
Class	Subclass	Date	Examiner
720	655	11/3/2005	MK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR) (See Attached Search History)	11/3/2003	MK